Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/705,915	JEON ET AL.	
Examiner	Art Unit	
James J. Debrow	2176	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARC		ł
	DATE	EXMR
updated EAST text search	12/17/2007	JD
updated ACM database search (see search notes)	12/21/2007	JD
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